Search Notes Application/Control No. Applicant(s)/Patent Under Reexamination SPILMAN ET AL. Examiner Liu, Li 2613

SEARCHED					
Class	Subclass	Date	Examiner		
398	27-33, 135-139	11/29-12/06, 20- 06	LL		
375	222-225, 324	11/29-12/06, 2006	LL		
370	230-244, 329, 389-505	11/29-12/06, 2006	LL		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST: US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB	11/29-12/06, 2006, 5/17-5/21, 2007, 8/1- 8/3,/2007, 1/3- 1/12, 2008; 7/31-81, 2008	LL		
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PLUS	5/17/2007	LL		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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